EMC TEST REPORT

Report No.:	SET2015-03289
Product Name:	Industrial Handheld Terminal
FCC ID:	2AC68-AUTOID9
Model No. :	AUTOID 9 /AUTOID9HC
Applicant:	Jiangsu SEUIC Technology CO.,Ltd.
Address:	No 23, Wenzhu Road,Yuhuatai District,Nanjing,Jiangsu,China
Received Date:	2015.12.31
Tested Date:	2015.01.07—2015.02.25
Issued by:	CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd.
Lab Location:	Electronic Testing Building, Shahe Road, Xili, Nanshan District, Shenzhen, 518055, P. R. China
	Tel: 86 755 26627338 **Fax:** 86 755 26627238

This test report consists of **21** pages in total. It may be duplicated completely for legal use with the approval of the applicant. It should not be reproduced except in full, without the written approval of our laboratory. The client should not use it to claim product endorsement by CCIC-SET. The test results in the report only apply to the tested sample. The test report shall be invalid without all the signatures of testing engineers, reviewer and approver. Any objections must be raised to CCIC-SET within 20 days since the date when the report is received. It will not be taken into consideration beyond this limit.

Test Report

Product Name ..... :	Industrial Handheld Terminal
Model No. ..... :	AUTOID 9 /AUTOID9HC
Applicant ..... :	Jiangsu SEUIC Technology CO.,Ltd.
Applicant Address ..... :	No 23, Wenzhu Road,Yuhuatai District,Nanjing,Jiangsu,China
Manufacturer ..... :	Jiangsu SEUIC Technology CO.,Ltd.
Manufacturer Address ..... :	Nanjing High-tech Development Zone software center 406#
Test Standards ..... :	47 CFR Part 15 Subpart B: Radio Frequency Devices
Test Result ..... :	PASS
Tested by ..... :	Xiaolong Zhang 2015.03.13 Xiaolong Zhang, Test Engineer
Reviewed by ..... :	Shuangwen Zhang 2015.03.13 Shuangwen Zhang, Senior Engineer
Approved by ..... :	Wu Lian 2015.03.13 Wu Li'an, Manager

TABLE OF CONTENTS

1. GENERAL INFORMATION 4

1.1 EUT Description 4

1.2 Test Standards and Results 5

1.3 Facilities and Accreditations 6

1.3.1 Facilities 6

1.3.2 Test Environment Conditions 6

1.3.3 Measurement Uncertainty 6

2. TEST CONDITIONS SETTING 7

2.1 Test Peripherals 7

2.2 Test Mode 7

2.3 Test Setup and Equipments List 8

2.3.1 Conducted Emission 8

2.3.2 Radiated Emission 8

3. 47 CFR PART 15B REQUIREMENTS 11

3.1 Conducted Emission 11

3.1.1 Requirement 11

3.1.2 Test Description 11

3.1.3 Test Result 11

3.2 Radiated Emission 14

3.2.1 Requirement 14

3.2.2 Test Description 15

3.2.3 Test Result 15

4. PHOTOGRAPHS OF THE EUT 19

5. PHOTOGRAPHS OF THE TEST SET-UP 20

Change History		
Issue	Date	Reason for change
1.0	2015.03.13	First edition

1. GENERAL INFORMATION

1.1 EUT Description

EUT Name ..... :	Industrial Handheld Terminal	
Serial No..... :	P16E709D4784010	
IMEI No. . ..... :	352482033215041	
FCC ID ..... :	2AC68-AUTOID9	
Trade Name……..:	AUTOID	
Brand Name……..:	SEUIC	
Hardware Version..... :	D500_Main	
Software Version ..... :	3.4.0	
Power Supply ..... :	Battery	
	Brand Name:	SEUIC
	Model No.:	MZ615LI
	Capacitance:	3920mAh
	Rated Voltage:	3.8V
	Charge Limit:	4.2V
Ancillary Equipment 1 ..... :	AC Adapter (Charger for Battery)	
	Brand Name:	/
	Model No.:	SW-1777
	Rated Input:	100-240V, 50/60Hz ,500mA
	Rated Output:	5V⎓1.5A

Note1:The EUT is a Mobile phone, it supports the following operating frequency band:GSM850/1900, WCDMA850,GPS, RFID,802.11b,802.11g,802.11n/20M, 802.11n/40M and bluetooth4.0.

Note2:The EUT is equipped with a T-Flash card slot; equipped with a USB port which can be connected to the ancillary equipments.

Note 3: The EUT has two models: AUTOID 9 and AUTOID9HC.They have the same size, internal structure, PCB, material and function. Only one is different for key board.One button is seventeen(which is model AUTOID 9), the other button is twenty two(which is model AUTOID9HC).So all the test is in the model AUTOID9HC and add different test of AUTOID 9.

Note 4:For a more detailed description, please refer to Specification or User's Manual supplied by the applicant and/or manufacturer.

1.2 Test Standards and Results

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title
1	47 CFR Part 15 Subpart B 2013	Radio Frequency Devices

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Result
1	15.107	Conducted Emission	PASS
2	15.109	Radiated Emission	PASS

NOTE:

(1) The EUT has been tested according to 47 CFR Part 15 Subpart B,Class B.The test procedure is according to ANSI C63.4:2014.

1.3 Facilities and Accreditations

1.3.1 Facilities

CNAS-Lab Code: L1659

CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd. CCIC is a third party testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L1659. A 12.8*6.8*6.4 (m) fully anechoic chamber was used for the radiated spurious emissions test.

FCC-Registration No.: 406086

CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. Registration 406086, valid time is until October 28, 2017.

1.3.2 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15°C - 35°C
Relative Humidity (%):	25% -75%
Atmospheric Pressure (kPa):	86kPa-106kPa

1.3.3 Measurement Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission:	Uc = 3.6 dB (k=2)
Uncertainty of Radiated Emission:	Uc = 4.5 dB (k=2)

2. TEST CONDITIONS SETTING

2.1 Test Peripherals

The following is a listing of the EUT and peripherals utilized during the performance of EMC test:

Description	Manufacturer	Model	Serial No.	FCCID /DOC
Notebook	ThinkPad	E430C	A131101550	/
Micro SD card	SanDisk	/	/	/
earphone	/	/	A131101551	/
Mouse	Microsoft	1068	/	DOC

2.2 Test Mode

(1) The first test mode

The EUT configuration of the emission tests is TransFlash Card + EUT + Battery + PC.

In this test mode, the EUT with a TransFlash Card embedded is connected with a PC via a USB cable supplied by applicant. During the measurement, the data is transmitting between the PC and the TransFlash Card of the EUT.

(2) The second test mode

The EUT configuration of the emission tests is Internal memory+ EUT + Battery + PC.

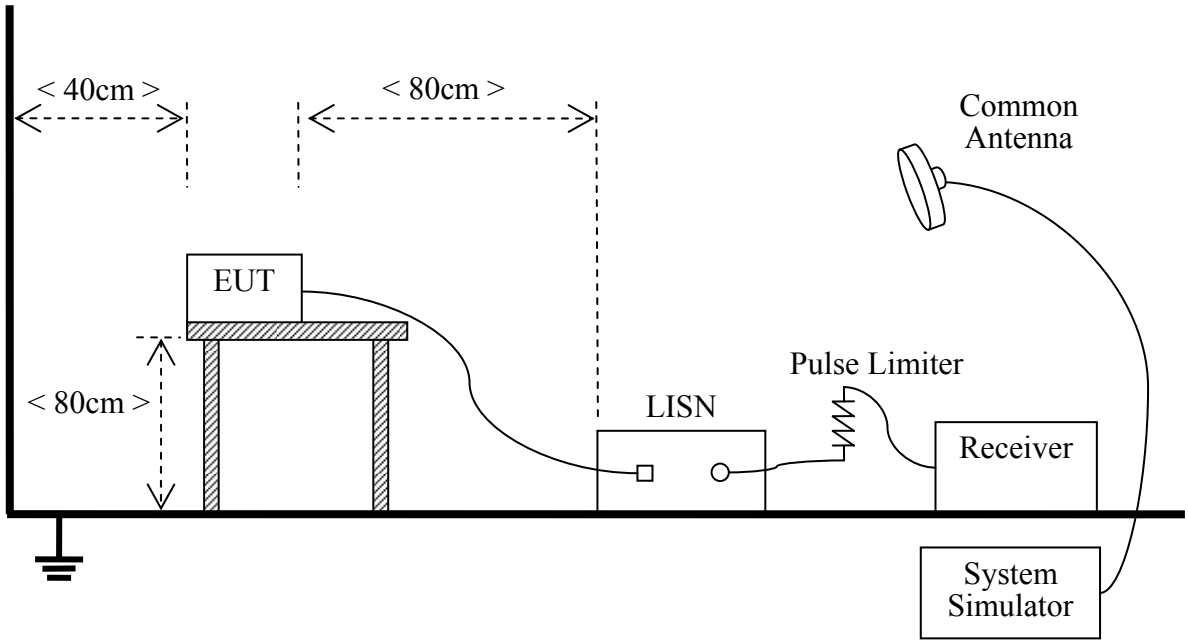
In this test mode, the EUT with a Internal memory is connected with a PC via a USB cable supplied by applicant. During the measurement, the data is transmitting between the PC and the Internal memory of the EUT.

NOTE: All test modes are performed, only the worse case（the first test mode）is recorded in this report.

2.3 Test Setup and Equipments List

2.3.1 Conducted Emission

A. Test Setup:



The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides 50Ω/50μH of coupling impedance for the measuring instrument. The Common Antenna is used for the call between the EUT and the System Simulator (SS). A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

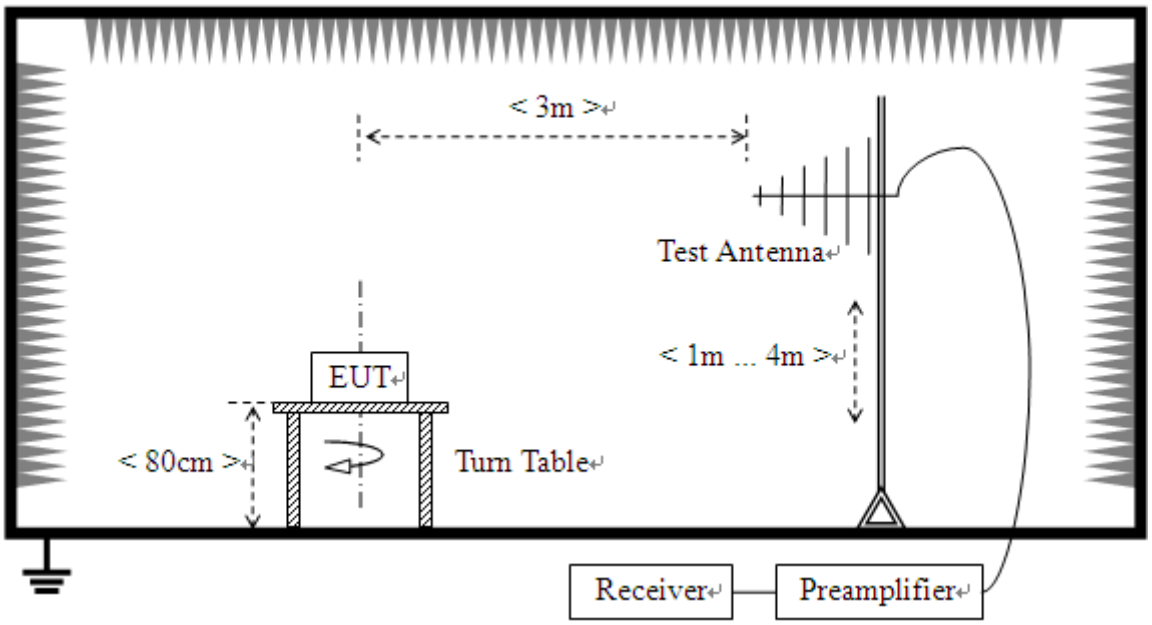
B. Equipments List:

Description	Manufacturer	Model	Serial No.	Calibration Date	Calibration Due. Date
Test Receiver	ROHDE&SCHWARZ	ESCI	A130901475	2014.09.09	2015.09.08
LISN	ROHDE&SCHWARZ	ENV216	/	2014.04.28	2015.04.27
Cable	MATCHING PAD	W7	/	2014.06.05	2015.06.04

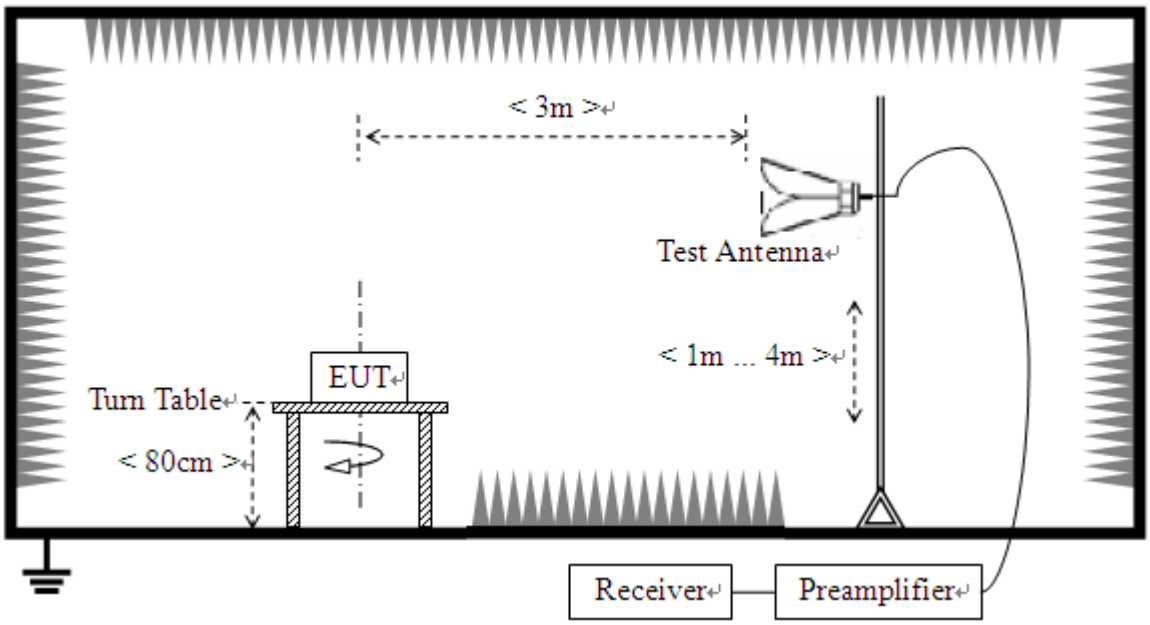
2.3.2 Radiated Emission

A. Test Setup:

1) For radiated emissions from 30MHz to1GHz



2) For radiated emissions above 1GHz



B. Test Procedure

The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a

variable-height antenna master tower.

For the test Antenna:

1) In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

C. Equipments List:

Description	Manufacturer	Model	Serial No.	Calibration Date	Calibration Due. Date
Test Receiver	ROHDE&SCHWARZ	ESIB7	A0501375	2014.06.10	2015.06.09
Test Receiver	ROHDE&SCHWARZ	ESIB26	A0304218	2014.06.10	2015.06.09
Semi-Anechoic Chamber	Albatross	9m*6m*6m	A0412372	2014.03.22	2015.03.21
Test Antenna - Bi-Log	HP	CBL6111A	A9704202	2014.06.10	2015.06.09
Test Antenna – Horn	ROHDE&SCHWARZ	HF906	A0304225	2014.06.10	2015.06.09
Anechoic Chamber	Albatross	SAC-5MAC 12.8x6.8x6.4m	A0304210	2014.03.22	2015.03.21
Amplifier 1G~18GHz	ROHDE&SCHWARZ	MITEQ AFS42-00101800	A0509366	2014.06.10	2015.06.09
Amplifier 20M~3GHz	Compliance Direction System	PAP-0203H	A0509377	2014.06.10	2015.06.09
Cable	SUNHNER	SUCOFLEX 100	/	2014.06.10	2015.06.09
Cable	SUNHNER	SUCOFLEX 104	MY1758/4	2014.06.10	2015.06.09

3. 47 CFR PART 15B REQUIREMENTS

3.1 Conducted Emission

3.1.1 Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a 50μH/50Ω line impedance stabilization network (LISN).

Frequency range (MHz)	Conducted Limit (dBμV)	
	Quasi-peak	Average
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

a) The limit subjects to the Class B digital device.

b) The lower limit shall apply at the band edges.

c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50MHz.

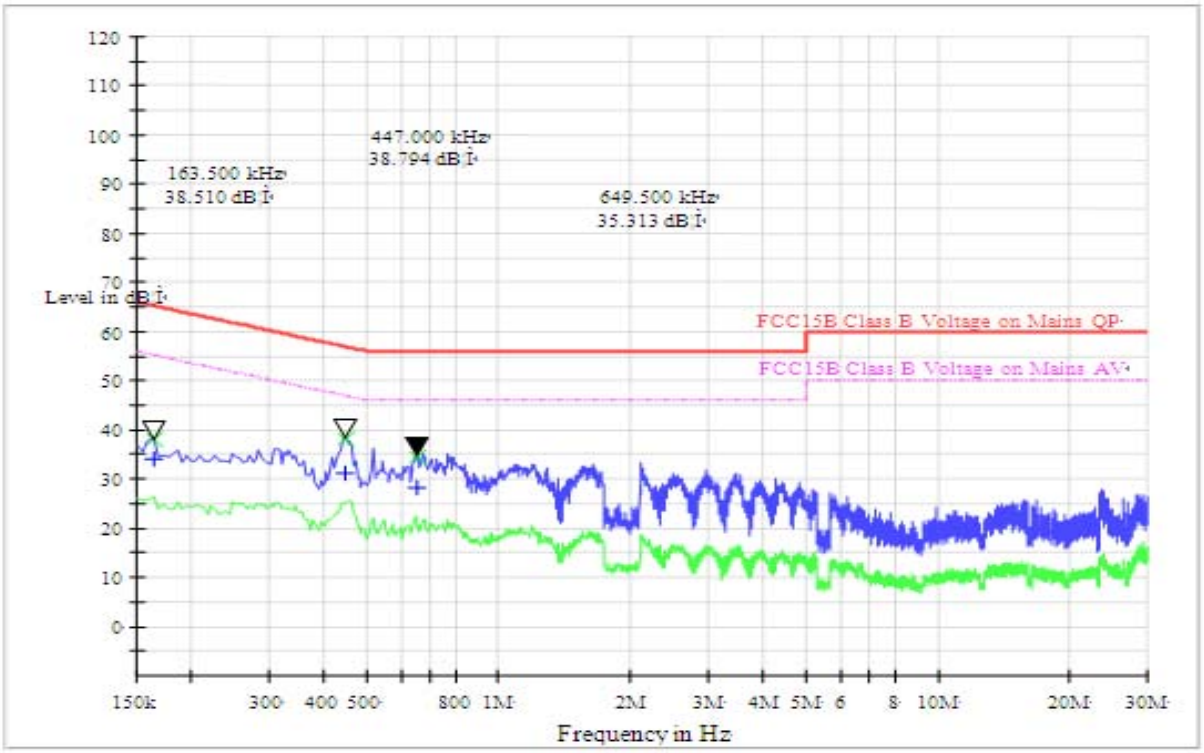
3.1.2 Test Description

See section 2.3.1 of this report.

3.1.3 Test Result

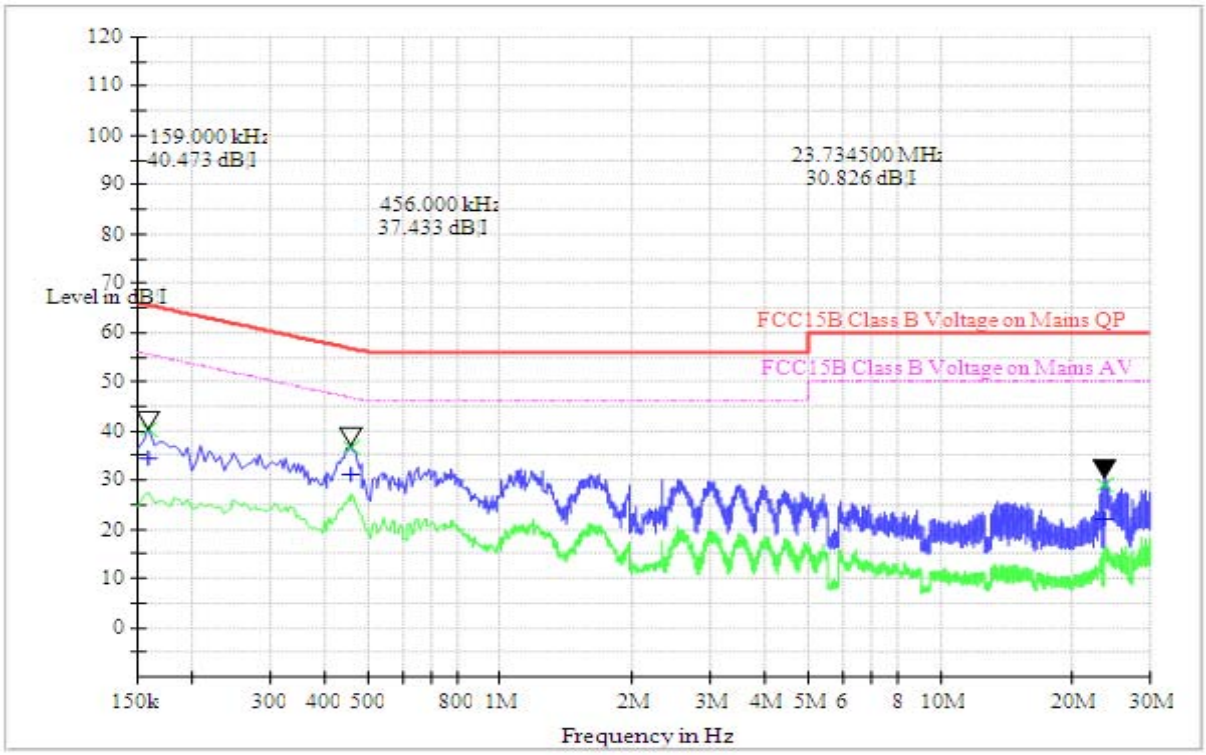
The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

A. Test Plot and Suspicious Points:



(Plot A: L Phase)

Conducted Disturbance at Mains Terminals							
L Test Data							
QP				AV			
Frequency (MHz)	Limits (dBµV)	Measurement Value (dBµV)	Margin (dB)	Frequency (MHz)	Limits (dBµV)	Measurement Value (dBµV)	Margin (dB)
0.1635	65.30	37.93	27.37	0.1635	55.30	34.18	21.12
0.4470	56.90	38.18	18.72	0.4470	46.90	31.11	15.79
0.6495	56.00	34.60	21.40	0.6495	46.00	28.10	17.90



(Plot B: N Phase)

Conducted Disturbance at Mains Terminals							
N Test Data							
QP				AV			
Frequency (MHz)	Limits (dBµV)	Measurement Value (dBµV)	Margin (dB)	Frequency (MHz)	Limits (dBµV)	Measurement Value (dBµV)	Margin (dB)
0.1590	65.50	40.17	25.33	0.1590	55.50	34.30	21.20
0.4560	56.80	36.56	20.24	0.4560	46.80	31.30	15.50
23.7345	60.00	29.01	30.99	23.7345	50.00	21.93	28.07

Test Result: PASS

3.2 Radiated Emission

3.2.1 Requirement

According to FCC section 15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency range (MHz)	Field Strength		Field Strength Limitation at 3m Measurement Dist	
	μV/m	Dist	(uV/m)	(dBuV/m)
0.009 - 0.490	2400/F(kHz)	300m	10000* 2400/F(kHz)	20log 2400/F(kHz) + 80
0.490 - 1.705	2400/F(kHz)	30m	100* 2400/F(kHz)	20log 2400/F(kHz) + 40
1.705 - 30.00	30	30m	100*30	20log 30 + 40
30.0 - 88.0	100	3m	100	20log 100
88.0 - 216.0	150	3m	150	20log 150
216.0 - 960.0	200	3m	200	20log 200
Above 960.0	500	3m	500	20log 500

a) As shown in FCC section 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.

b) Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength.

c) For below 1G :QP detector RBW 120kHz ,VBW 300kHz.

d) For Above 1G: PK detector RBW 1MHz,VBW 3MHz for PK value ;PK detector RBW 1MHz, VBW 10Hz for AV value.

Note:

1) The tighter limit shall apply at the boundary between two frequency range.
2) Limitation expressed in dBuV/m is calculated by 20log Emission Level(uV/m).
3) If measurement is made at 3m distance, then F.S Limitation at 3m distance is adjusted by using the formula of $Ld1 = Ld2 * (d2/d1)^{2.}$
   Example:
   F.S Limit at 30m distance is 30uV/m, then F.S Limitation at 3m distance is adjusted as
   $Ld1 = L1 = 30uV/m * (10)^2 = 100 * 30uV/m.$

3.2.2 Test Description

See section 2.3.2 of this report.

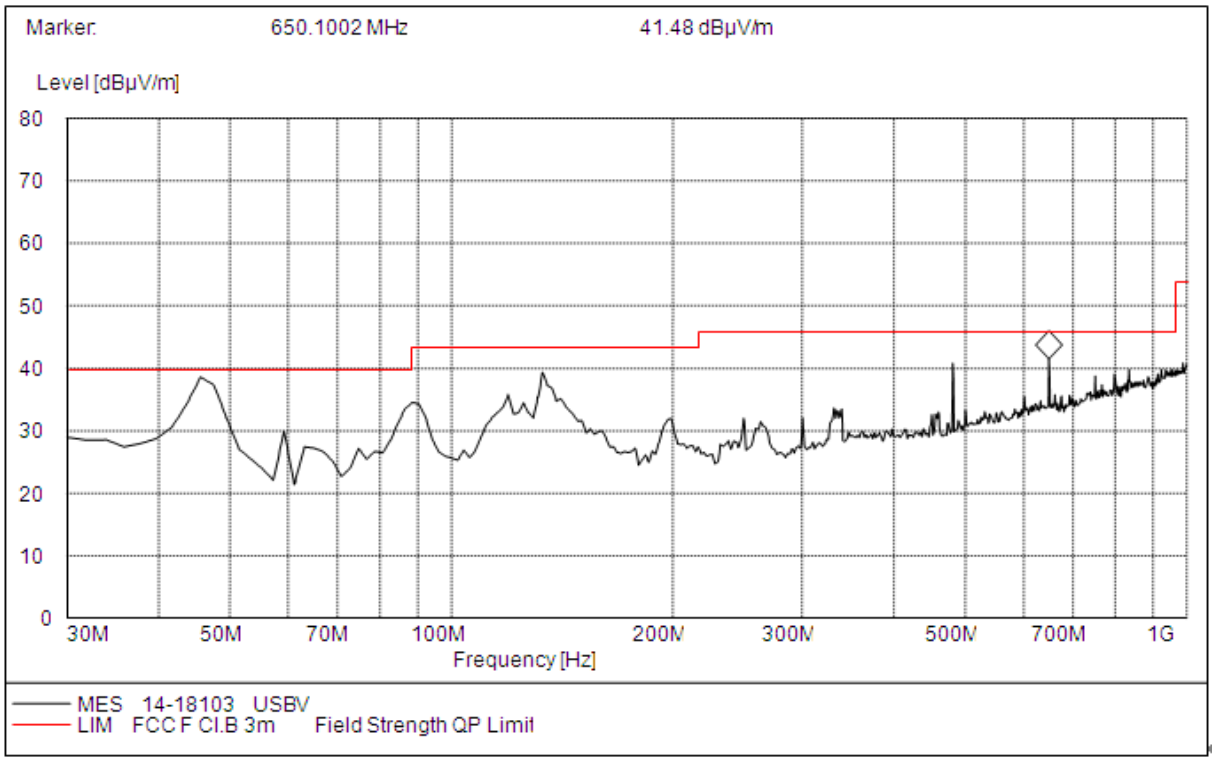
3.2.3 Test Result

The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

The amplitude of spurious emissions which are attenuated more than 20 dB below the permissible value need not be reported.

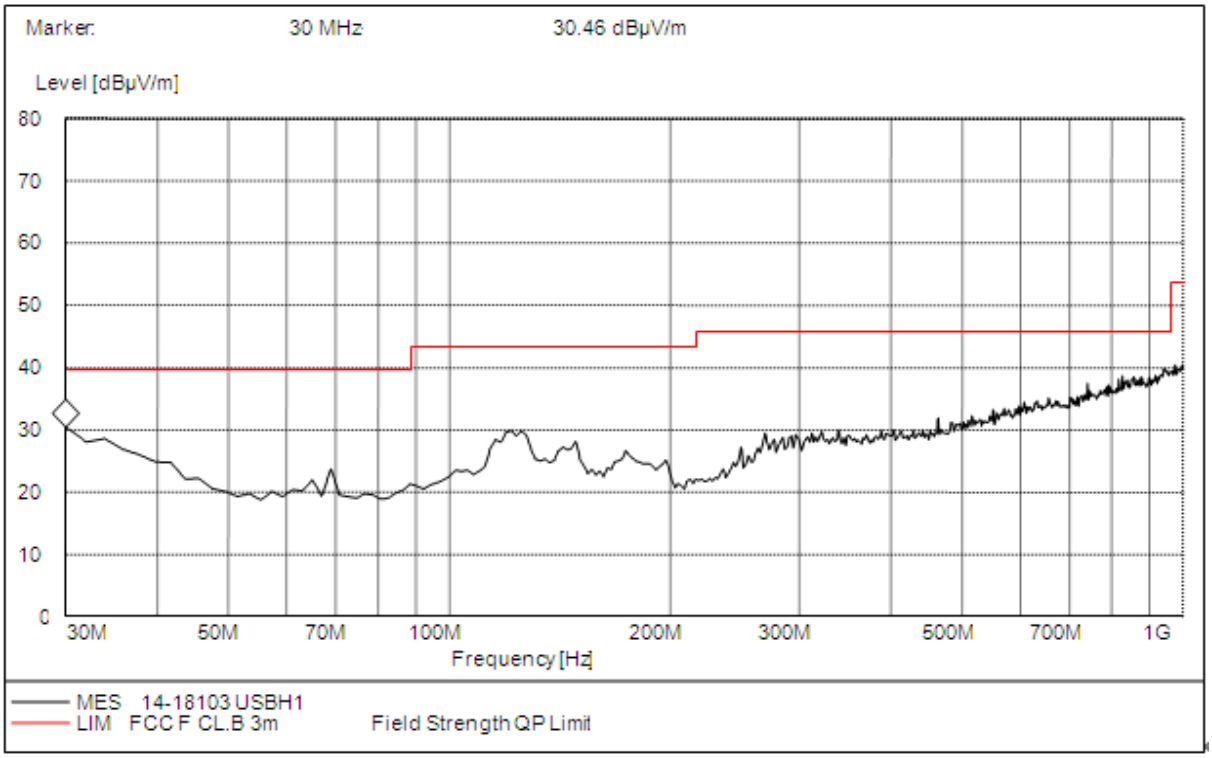
Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.

B. Test Plots and Suspicious Points:



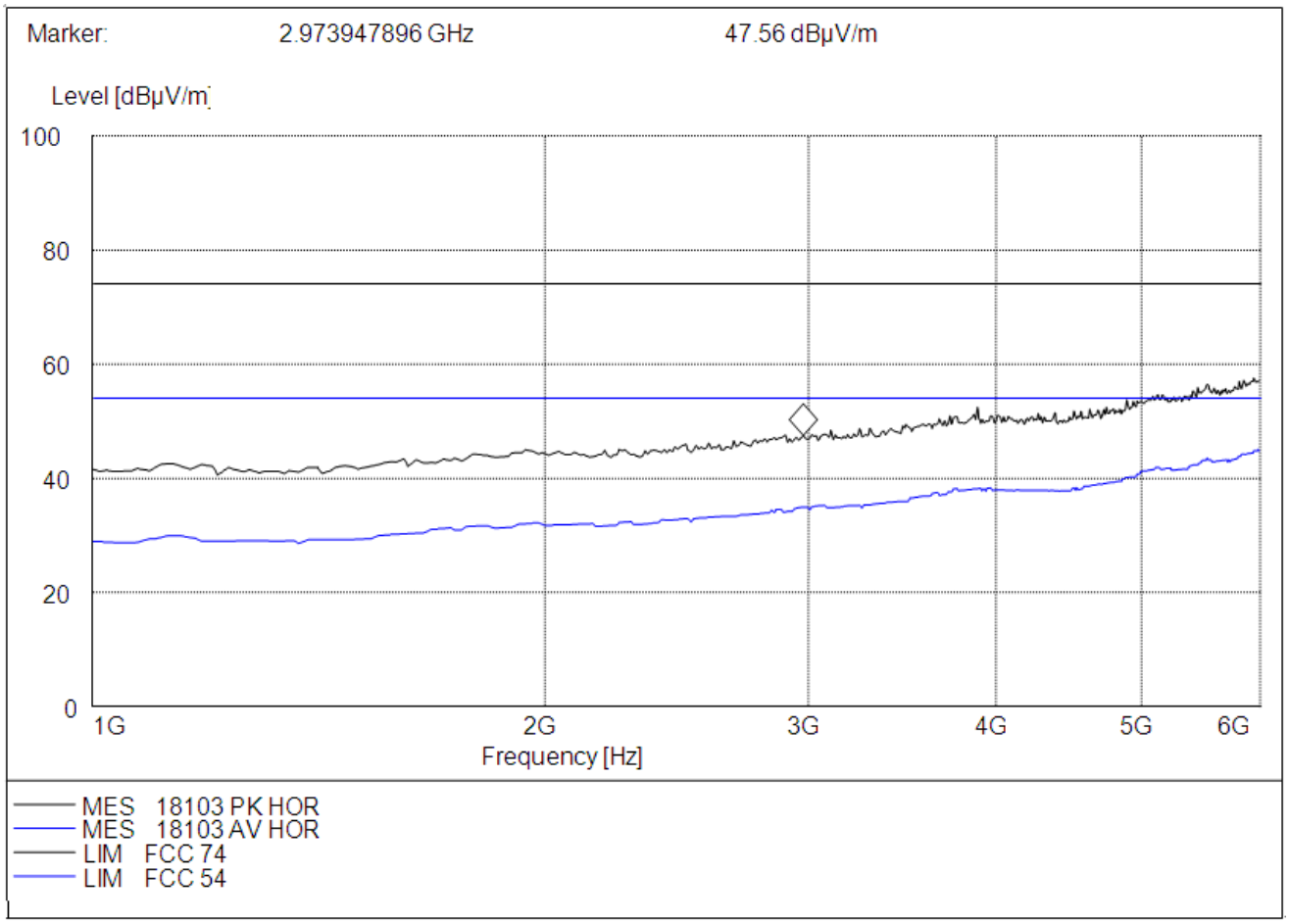
(Plot C: Test Antenna Vertical 30M - 1G)

Frequency (MHz)	QuasiPeak (dB μ V/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dB μ V/m)	Margin (dB)	Antenna	Verdict
133.69000	38.59	120.000	100.0	43.50	4.91	Vertical	Pass
480.26000	40.16	120.000	100.0	46.00	5.84	Vertical	Pass
650.13000	40.56	120.000	100.0	46.00	5.44	Vertical	Pass



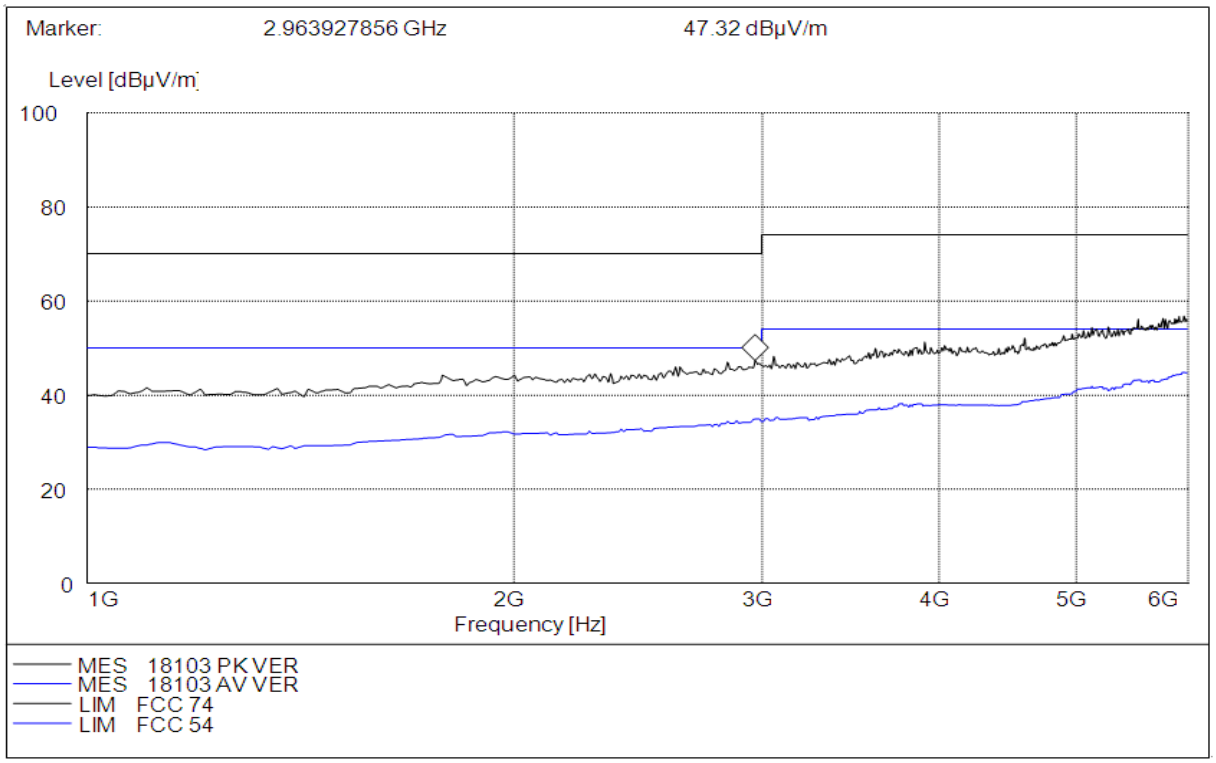
(Plot D: Test Antenna Horizontal 30M - 1G)

Frequency (MHz)	QuasiPeak (dBμV/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dBμV/m)	Margin (dB)	Antenna	Verdict
30.36000	28.67	120.000	100.0	40.00	11.33	Horizontal	Pass
119.09000	28.29	120.000	100.0	43.50	15.21	Horizontal	Pass
740.13000	35.25	120.000	100.0	46.00	10.75	Horizontal	Pass



(Plot E: Test Antenna Horizontal 1G – 6G)

Frequency (MHz)	PK/AV (dBµV/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dBµV/m)	Margin (dB)	Antenna	Verdict
1150.10090	31.68	1000.000	150.0	54.00	22.32	Horizontal	Pass
1930.76352	32.65	1000.000	150.0	54.00	21.35	Horizontal	Pass
2973.72456	34.55	1000.000	150.0	54.00	19.45	Horizontal	Pass
1150.10090	42.68	1000.000	150.0	74.00	31.32	Horizontal	Pass
1930.76352	43.83	1000.000	150.0	74.00	30.17	Horizontal	Pass
2973.72456	47.02	1000.000	150.0	74.00	26.98	Horizontal	Pass



(Plot F: Test Antenna Vertical 1G – 6G)

Frequency (MHz)	PK/AV (dBµV/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dBµV/m)	Margin (dB)	Antenna	Verdict
1100.21090	29.73	1000.000	100.0	54.00	24.27	Vertical	Pass
1821.76452	31.26	1000.000	150.0	54.00	22.74	Vertical	Pass
2963.24549	34.28	1000.000	100.0	54.00	19.72	Vertical	Pass
1100.21090	40.26	1000.000	150.0	74.00	33.74	Vertical	Pass
1821.76452	41.58	1000.000	100.0	74.00	32.42	Vertical	Pass
2963.24549	46.92	1000.000	150.0	74.00	27.08	Vertical	Pass

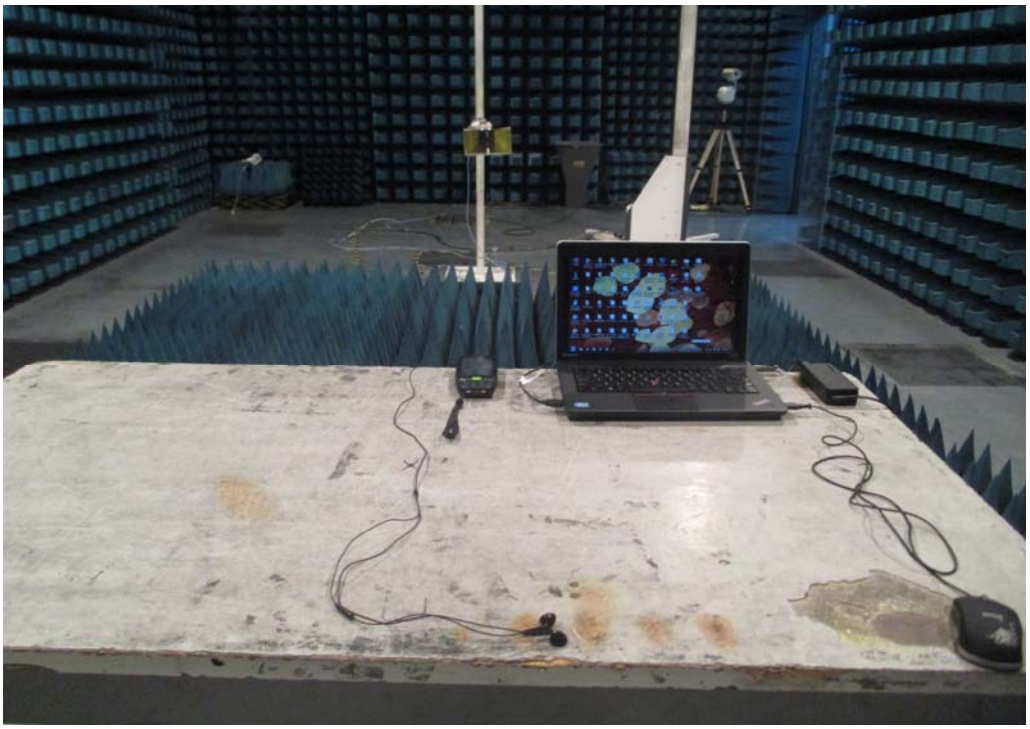
Test Result: PASS

4. PHOTOGRAPHS OF THE EUT

5. PHOTOGRAPHS OF THE TEST SET-UP

Conducted Emission

Radiated Emission of 30M-1G



Radiated Emission of 1-6G

** END OF REPORT **